

Laser Diode Testing Equipment



Overview

Laser Diode Test Equipment | Suppliers Explore 28 top manufacturers and suppliers of Laser Diode Test Equipment in our comprehensive photonics buyers' guide.

Key Takeaways

Laser diode testing machines are specialized systems designed to measure electrical and optical characteristics of laser diodes, ensuring performance, reliability, and quality control in both R&D and mass production.

Laser diode testing machines are used to evaluate the electrical and optical performance of laser diodes and modules. Key parameters measured include LIV characteristics (Light output vs. Current vs. Voltage), wavelength, beam profile, and far-field emission patterns. Testing ensures that diodes meet specifications, identifies early failures, and supports long-term reliability assessments through processes like production burn-in and accelerated aging .

Types of Laser Diode Testing Machines

- Fully Automatic Module Testers Machines like the VMSB-2000 integrate automated handling and testing for laser diode modules. They feature input/output cassettes, vacuum collets for precise module transfer, and multiple bins for sorting based on test results. These systems are suitable for high-volume production and R&D, providing fast, repeatable measurements of optical and electrical parameters .

- **TO-CAN Package Test Systems** Systems such as the TO6201-LD are designed for TO-CAN packaged devices at room and high temperatures. They support various fixture types, reduce material handling, and maintain consistent test conditions. These testers are widely used in high-speed communication, 5G, and optical transceiver testing .
- **High-Power Laser Diode Testers** High-power diodes require specialized systems for LIV curve measurement, optical spectrum analysis, and near/far-field characterization. Automated systems, like those from ficonTEC, integrate electronic and photonic devices for miniaturized, high-volume testing, with data stored in SQL databases for statistical analysis and yield tracking .
- **Die-Level Testers** Machines like the CT8203 perform wafer-level and chip-level testing under dual temperature zones. They include wafer supply, chip handling, position correction, OCR extraction, and high/low temperature testing. These systems are optimized for high-throughput production, completing LIV and spectral measurements in seconds .

Key Features

- **Automated Handling:** Vacuum collets and robotic arms for precise module transfer.
- **Temperature Control:** Dual-zone or high/low temperature testing for reliability assessment.
- **Electrical and Optical Measurement:** LIV scanning, forward/backward photoelectric tests, and spectral analysis.
- **Sorting and Binning:** Modules are automatically sorted into OK or NG bins based on test results.
- **Data Management:** Integration with databases for statistical analysis, yield tracking, and quality control.

Applications

- **R&D:** Characterization of new laser diode designs and process validation.
- **Mass Production:** High-speed testing and sorting to ensure consistent product quality.
- **Reliability Testing:** Burn-in and accelerated aging to predict long-term performance.
- **Optical Communication:** Testing components for 5G, cloud computing, and high-speed data networks. Laser diode testing machines are essential for ensuring high performance, reliability, and long lifetimes of laser diodes, supporting both development and large-scale manufacturing processes .

Article Content

LD Module Tester VMSB2000 | Opto System Co., Ltd.

The Fully Automatic Laser Diode Module Tester VMSB-2000 is designed to meet the high-quality material handling and test

Chroma 58605 High Power Laser Diode Burn-In and Reliability Test

Chroma 58605 is a high density, multi-function, and temperature-controlled module based system for laser diode burn-in and lifetime

Laser Diode Reliability, Burn-In and Life-Test System

Chroma 58602 is a high density, precision multi Source Measurement Unit (SMU) module with temperature control and

TEST LOAD BASICS – Wavelength Electronics

To test or understand the photodiode feedback and current monitor circuits, you can replace the constant current test load with one

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